



## Double Michelson Interferometer for Contactless Length Change Measurements

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Interim Report

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Gerhard E. Aichinger

Project Officer

FOR THE COMMANDER

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UNCLASSIFIED SECURITY CLASSIFICATION OF THIS PAGE (When Date Entered) READ INSTRUCTIONS BEFORE COMPLETING FORM 19 REPORT DOCUMENTATION PAGE 2. GOVT ACCESSION NO TRIENT'S CATALOG NUMBER SAMSO TR-78-136 DOUBLE MICHELSON INTERFEROMETER FOR CONTACTLESS LENGTH CHANGE MEASUREMENTS. TR-0079(4950-01)-1 7. AUTHOR(s) CONTRACT OR GRANT NUMBER (a) FØ47Ø1-78-C-0079 Ernest G. Wolff Steve A. Eselun 9. PERFORMING ORGANIZATION NAME AND ADDRESS 10. PROGRAM ELEMENT, PROJECT, TASK AREA & WORK UNIT NUMBERS The Aerospace Corporation El Segundo, Calif. 90245 11. CONTROLLING OFFICE NAME AND ADDRESS 12. REPORT DATE 6 November 278 Space and Missile Systems Organization Air Force Systems Command Los Angeles, Calif. 90009

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19. KEY WORDS (Continued)

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20. ABSTRACT (Continued)

 $\Delta T$  varies from 25 to 250 C. An average coefficient of thermal expansion for ultralow-expansion glass, measured with additional fringe interpolation by photo-detector signal analysis, would be known to  $\pm 1.2 \times 10^{-9}$  ° C<sup>-1</sup>.

+ or - 1.2 times 10 to the -9th power / deg-C

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#### I. INTRODUCTION

The advantages of reflected laser beams for the measurement of dimensions in changing thermal environments have been documented.<sup>1</sup>, <sup>2</sup>

The use of interferometric techniques for these measurements results in the elimination of dependence on a reference material. The laser frequency can be readily known and stabilized, through use of the Lamb dip, to one part in 10<sup>9</sup> in 500 hr. <sup>1</sup> When all the optics are placed in the test (vacuum) chamber, there is no possible error from refraction in beam paths, window effects, or operators, since all information is generated at the beam splitter(s).

A Michelson interferometer was originally used in The Aerospace Corporation Materials Sciences Laboratory (MSL) to study length changes of samples heated to ±250 C. <sup>1</sup> In this case, one arm of the interferometer included both ends of the test sample, which resulted in a large optical path length (OPL) difference between the two beams required to recombine in order to form the necessary fringe pattern. An extensive analysis indicated that there are several possible sources of error inherent in this approach. <sup>1</sup> Because the OPL of the sample was so much greater (70 times) than that to the reference mirror, errors could arise as a result of differences in pressure or temperature of the residual gas in the two OPLs. More importantly, because all the optics used in the sample OPL were held on the same support plate, any temperature changes in any part of this plate would change the sample OPL, which the interferometer would then confuse with a sample length change. In principle, this error could be avoided by a zero coefficient of thermal expansion (CTE) support plate. This would be approximated by

E. G. Wolff and S. A. Eselun, Absolute Length Changes by Remote Interferometry, TR-0076(6950-07)-1, The Aerospace Corp., El Segundo, Calif. (10 December 1975).

<sup>&</sup>lt;sup>2</sup>E. G. Wolff, "Measurement Techniques for Low Expansion Materials, Nat. SAMPE Tech. Conf. Ser. 9, 57 (1977).

ultralow-expansion glass (ULE) near room temperature (CTE  $\sim 0 \pm 0.03 \times 10^{-6}$  °C<sup>-1</sup>). A sufficiently large and stiff plate, however, is extremely expensive (stiffness provides immunity from vacuum chamber distortions on pumpdown or ambient temperature fluctuations). The error might also be avoided by the use of a water-cooled copper baseplate attached to a thermostatically controlled bath. Undesirable vibration could result, however, because the optics would have to be attached rigidly to the plate. Another problem with a one-channel interferometer is that 10 or 11 reflections must be aligned sequentially for recombination with a reference beam.

## II. THEORY OF TWO-CHANNEL INTERFEROMETER

The principles of a two-channel Michelson interferometer are illustrated in Fig. 1. The original laser beam (frequency-stabilized He-Ne) is split 50/50 at beam splitter BS3 into right and left (sample) side interferometers. With the sample ends designated S and the mirrors M, it can be seen that, for the right-hand side, the interferometer optical path length difference (OPLD) is

$$OPLD_1 = \overline{B_1S_1} - \overline{B_1M_6}$$
 (1)

Similarly

$$OPLD_2 = \overline{B_2M_5} - \overline{S_2M_4} - \overline{B_2M_4}$$
 (2)

Now

$$\Delta \text{OPLD}_2 - \Delta \text{OPLD}_1 = \overline{\Delta \text{B}_2 \text{M}_5} - \overline{\Delta \text{S}_2 \text{M}_4} - \overline{\Delta \text{B}_2 \text{M}_4} - \overline{\Delta \text{B}_1 \text{S}_1} + \overline{\text{B}_1 \text{M}_6} \tag{3}$$

Assume that

$$\Delta \overline{B_2 M_4} = \Delta \overline{B_1 M_6}$$
 (a)

$$\overline{\Delta B_1 M}_4 = \overline{\Delta B_2 M}_5 \tag{b}$$

Note that

$$\overline{\Delta B_1 M_4} = \overline{\Delta S_2 M_4} + \Delta L_s + \overline{\Delta S_1 B_1}$$

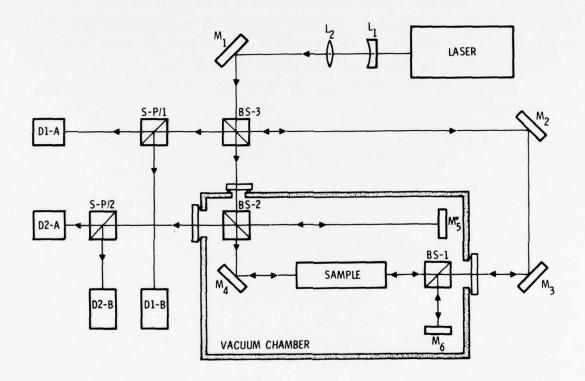


Fig. 1. Two-Channel Michelson Interferometer

where  $\boldsymbol{L}_{\boldsymbol{s}}$  is the sample length. Hence

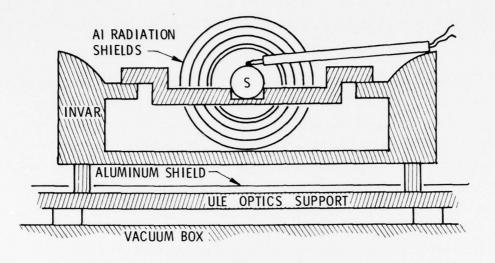
$$\Delta L_s = \Delta OPLD_2 - \Delta OPLD_1$$
 (4)

Consequently, the sample length change  $\Delta L_{\mbox{\scriptsize S}}$  is merely the difference between the changes in the two OPLDs.

#### III. EXPERIMENTAL APPARATUS AND PROCEDURE

Three methods studied to support the test sample are illustrated in Figs. 2 through 4. In all cases, the cross section of the material is arbitrary, the length is limited only by the size of the vacuum chamber (and resultant optics separation) available, and the size is limited by the amount of heat flow (again chamber-size limited) the system can tolerate. Another sample support method that was investigated involves the use of axial adjacent quartz rods supported on ULE blocks outside the cooler/ heater unit. Expansion was discontinuous, probably because of sample weight-induced friction effects on the support used. The use of thin (~0.125-in. thick) horizontal transverse support rods (usually made of Invar) (Fig. 2), has met with much success, primarily because slight variations in heat flow along the rods have a minimal effect on the position of the sample in space, and the sample supports are approximately room temperature at all times. Temperature changes of the sample support are minimized by placing the support structure (Invar cylinders) far away from the sample (and heat or cold source). The large volume of Invar at the extremities of the 1/8-in. cross bars acts as a heat sink; these bars are designed to have low surface/volume ratio for this purpose. The surfaces are also polished to increase reflectance of radiation. Absorbant coatings on the sample help to increase the efficiency of heat transfer to the sample and to minimize heat flow to the supports.

The sample support shown in Fig. 3 was sensitive to small temperature gradients and hence caused sample rotations. High (Cu), medium (Invar), and low ( $SiO_2$ ) CTE supports were tried. An additional disadvantage of this approach is the conduction of heat to or from the optics support plate. The use of a copper plate to minimize temperature gradients in the optics support plate is also illustrated in Fig. 3. There is need for a zero-CTE (over  $\pm 250$  C) material to support the test sample. Plano convex



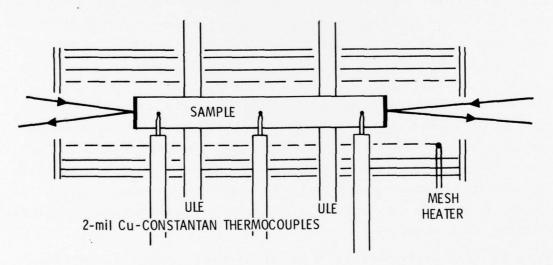


Fig. 2. Apparatus for Heating Cylindrical Samples

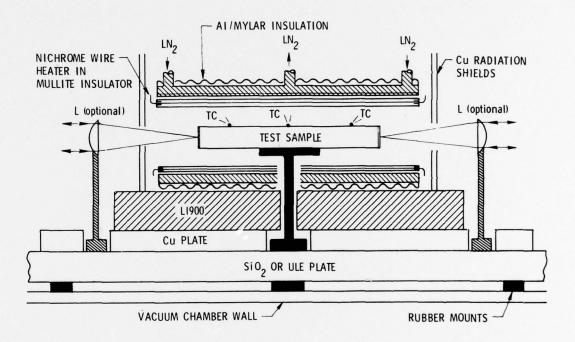


Fig. 3. Side View of Two-Channel Interferometer

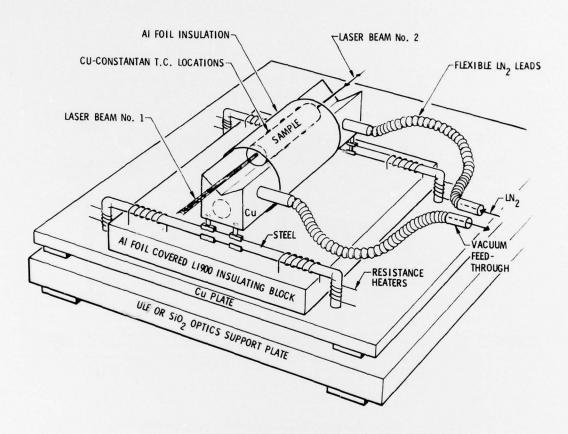


Fig. 4. Sample Support System for Ultralow Temperature Length Change Measurements

focusing lenses\* are also used to ensure that the reflected beams recombine with the reference beam in spite of small sample rotations. The system under test for very low temperature work is shown in Fig. 4. The radiation heat transfer method (Figs. 2 and 3) requires very long time periods to achieve temperatures much lower than -100 C. Cooling is a more difficult task than heating, not only because of reduced radiation heat transfer, but also because the required use of liquid N<sub>2</sub> or He imposes greater temperature gradients on the system.

The electronic signal processing used to convert the four photodetector signals to an analog voltage proportional to the sample length change is shown in Fig. 5. The SP beam splitters (SP1 and SP2) separate orthogonal components of the circularly polarized laser beam, an essential feature in detecting the directionality of fringe motion. The clipping circuit then digitizes the resulting silicon photodetector signals. By combining two dependent signals, the logic circuit is able to count the  $\Delta L$  changes in steps of  $\lambda/8$  and strain in steps of  $\lambda/8L_0$ , which, for a 4-in. sample, equals  $7.79 \times 10^{-7}$ . If required, interpolation can be achieved by recording the original analog voltage (Fig. 6); a 2  $\pi$  phase ( $\delta$ ) change is equivalent to  $\lambda/2$  and

$$V(signal) = V_{DC} + V_{AC} \cos \delta \tag{7}$$

With this technique,  $\delta$  can be obtained to high resolution. In general, however, system vibration and noise (which are phase dependent, as shown in Fig. 6) limit the sensitivity to  $\lambda/1000-\lambda/100$ .

<sup>\*</sup>E. G. Wolff and S. A. Eselun, "Thermal Expansion of a Fused Quartz Tube in a Dimensional Stability Test Facility," Rev. Sci. Instrum. (to be published, 1978).

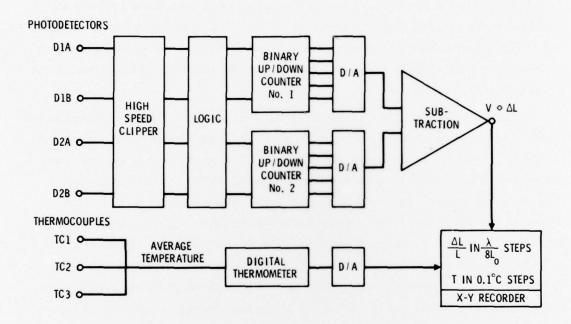


Fig. 5. Electronic Signal Processing from Two-Channel Interferometer

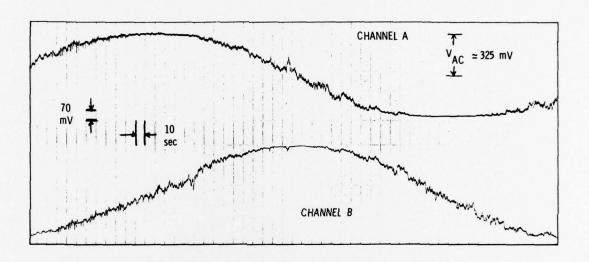


Fig. 6. Typical Photodetector Signals on Sample Heating

#### IV. ERROR ANALYSIS

The accuracy of the system, Eq. (4), depends on the validity of the assumptions (a) and (b). The combination of distance from the test sample and symmetry ensures that assumption (a) is incorrect by only a small amount, because the temperature difference between these regions is small ( $\leq 0.3$  C). Hence,

$$\Delta E_1 = \alpha \overline{B_2 M_4} \Delta T = (3 \times 10^{-8}) (2) (0.3) = 1.8 \times 10^{-8} \text{ in.}$$
 (8)

The strain error in a 4-in. sample then is  $4.5 \times 10^{-9}$ .

Assumption (b) is similarly incorrect, but the low CTE support plate ULE compensates for the greater significant length (20 in.) and somewhat higher temperature differentials. The copper plate (Figs. 3 and 4) is used to reduce temperature gradients to  $\leq 1$  C at the test temperature extremes. Hence,

$$\Delta E_2 = \overline{\alpha B_2 M_5} \Delta T = (3 \times 10^{-8}) (20) (1) \le 6 \times 10^{-7} \text{in.}$$
 (9)

and, for a 4-in. sample, the strain error is  $\leq 1.5 \times 10^{-7}$ .

Besides the design errors discussed above, problems may arise as a result of shifting of the sample ends relative to the laser beams and because of temperature gradients within the sample. Sample support rotations must be minimized in order to avoid signal loss. In practice, such losses occur before errors caused by off-axis beam reflectance become significant. Mere translation of the reflecting surface would not result in measurement errors if the end faces are parallel to each other and perpendicular to the sample axis. If there is a small angle  $\gamma$  between the end planes, and

shrinkage of support posts occurs, an error is induced even without sample expansion or contraction. It can be readily shown that this error is

$$\Delta E_3 = \ell_s \alpha_s \Delta T \gamma \tag{10}$$

where s refers to the support material in the direction perpendicular to the laser beam axis. For 1/8-in,-thick Invar supports (Fig. 2) and  $\gamma$  of 1 deg,  $\Delta E_3$  for  $\Delta T$  of 250 C is 5.45  $\times$  10<sup>-7</sup> in.; angle  $\gamma$  can be  $\sim$  8 deg before the strain error exceeds 1  $\mu \epsilon$  on a 4-in,-long test sample at the temperature extremes.

Thermal strain errors may arise if large (radial) temperature gradients are set up in the sample as a result of rapid heating or cooling. In the Appendix, it is shown that the length change error will be

$$\Delta E_4 = L_s \Delta \varepsilon = \frac{\alpha L_s (1 + v) (T_s - T_c)}{2(1 - 2v)}$$
 (11)

where  $\nu$  is the Poisson's ratio, and  $T_s$  and  $T_c$  are the surface (r = R) and center (r = 0) temperatures, respectively. It can be shown that, for times equal to or greater than  $R^2/a$ , where a is the thermal diffusivity, the gradient  $T_s - T_c$  remains constant at

$$T_s - T_c \approx \frac{1}{4} \frac{dT}{dt} \frac{R^2}{a}$$
 (12)

A 4-in. fused silica rod of 1/4-in. diam can achieve a steady gradient in about 12 sec (=  $R^2/a$ ). If  $\nu$  = 0.17,  $dT/dt\sim$ 5 C/min (0.083 C/s),  $\Delta E_4 \sim 4.4 \times 10^{-7}$ in. This error will decrease for higher thermal conductivity materials and slower rates.

#### V. EXPERIMENTAL RESULTS

The data in Fig. 7 were obtained from several tests of the NBS-SRM 739 fused silica standard ( $\ell_0$  = 3.35 in.), which was polished and lightly coated at the ends with a thin film of aluminum for reflectance. The scatter band is well within the NBS standard deviation of  $\pm 6 \times 10^{-6}$  in/in  $\Delta L/L$ . Some of the data obtained during these tests from reading two bidirectional counters ( $I_1$ ,  $I_2$ ) and a digital readout of the average temperature are given in Table 1. Since the three individual thermocouple readings were not read simultaneously, only their range about the average is indicated. This range decreases with higher conductivity materials.

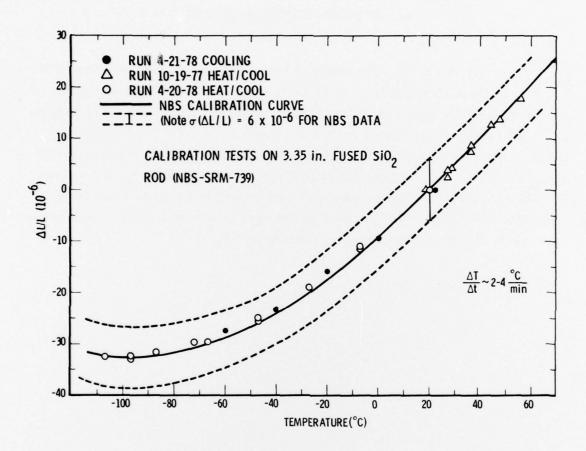


Fig. 7. Calibration Data Obtained with NBS-SRM-739 Fused Silica

Table 1. Typical Data Sheet for Sample Fused  $SiO_2$  (SRM 739)<sup>a</sup>

Time 4/20/78	T <sub>AV</sub> , K	TAV, C	T range, K	<sup>I</sup> 1	12	<sup>I</sup> 2 <sup>-I</sup> 1	ΔL/L, b X10-6
1:15	300	27	0	0	0	0	0
1:36	273	0	2	10	-2.5	-12.5	-11.6
1:41	263	- 10	2	14	-2	-16	-14.8
1:45	253	-20	2.5	16	-3.5	-19.5	-18.1
1:50	233	- 40	3	21.5	-6	-27.5	-25.5
1:55	208	-65	4	24	-7.5	-31.5	-29.2
2:00	183	-90	4.5	23	- 12	-35	-32.5
2:08	153	-120	5	12	-22	-34	-31.6
2:14	143	- 130	4	7	-25	-32	-29.7
2:27	153	- 120	5	2	-29	-31	-28.8
2:41	183	-90	6	14	-22	- 36	-33.4
2:54	213	-60	7	12	-20	-32	-29.7
3:01	233	- 40	5	9	- 18	-27	-25.1
3:28	300	27	5	10	- 10	0	0

<sup>&</sup>lt;sup>a</sup>NBS-SRM-739 uses  $T_o = 20$  C, not 27 C shown here. <sup>b</sup> $\Delta L/L = \lambda/8L_o (I_2 - I_1)$ 

#### VI. DISCUSSION

The interferometric technique may be refined by the use of thermoelectric cooling elements for complex-shaped samples. These elements are thermodynamically inefficient, however, and heat dissipation could cause problems. Thermal positioning actuators are being studied by means of the ultralow-temperature apparatus (Fig. 4). Results of preliminary tests indicate that slight sample rotations can be corrected by heating a sample support post. The use of a piezoelectric crystal attached to the  $M_6$  mirror (Fig. 1) may also improve the technique. Electronic control to maintain  $\Delta S_1 B_1 = \Delta B_1 M_6$  means that  $\Delta L_s = \Delta OPLD_2$  only, and that only one detection channel is required.

The most serious problem has involved signal losses that resulted from slight support rotations at the extreme temperatures and excessive time required to achieve very low temperatures. The ultralow-temperature apparatus (Fig. 4) is expected to correct these two remaining problems, neither of which affects measurement accuracy.

The sensitivity or resolution of the automatic recording system is  $\lambda/8$  (791Å, 3.11 µin. or  $7.78 \times 10^{-7}$  strain on a 4-in. sample). Fringe interpolation could be used to reduce these figures by a factor of about 100. The accuracy of these measurements, however (in principle, a measure of their traceability to a standard), is affected by thermal gradients in the system and by sample end face geometry. The former errors are approximately proportional to the sample temperature excursion, and thus the total strain values are more accurate at 0 or 50 C than at ±250 C. With all ULE optics supports,  $\gamma = 1$  deg and dT/dt = 2 C/min, the sum of all errors for a 250 C excursion equals  $3.34 \times 10^{-7}$  strain, equivalent to an rms strain error of  $2.07 \times 10^{-7}$  in a 4-in. sample. At 0 or 50 C, the latter figure diminishes to  $\sigma_{\rm c} = 4.8 \times 10^{-8}$ . An average CTE measurement on ULE

(where  $\varepsilon$  = +60  $\mu\varepsilon$  at -200 C) implies an rms error  $\sigma_{CTE}$  of 1.2  $\times$  10<sup>-9</sup>  $^{\circ}$  C<sup>-1</sup>. The error in  $\Delta T$  measurement is 0.7 C because it depends on temperature difference between two thermocouples that have an absolute accuracy of only about  $\pm 0.5$  C. Fringe interpolation would be needed in order to realize this accuracy in CTE inasmuch as the resolution of the automatic system is slightly greater than  $\sigma$ . The automatic system could then determine the CTE to  $\pm$  3.5  $\times$  10<sup>-9</sup>  $^{\circ}$  C<sup>-1</sup>.

#### APPENDIX

# CALCULATION OF STRAIN GRADIENT FOR CYLINDRICAL SPECIMENS FOR GIVEN TEMPERATURE DISTRIBUTIONS

With the surface temperature defined as

$$T_s = T_o + kt$$

where  $k = \Delta T/\Delta t$ , upon reaching steady state

$$T = T_o + kt - \frac{k}{4a} (R^2 - r^2)$$

and

$$T = T_0 + kt - \frac{kR^2}{8a}$$

where a is the thermal diffusivity. Under plane strain conditions

$$\sigma_{zz} = \frac{\alpha E}{1 - 2\nu} \left[ \frac{2}{R^2} \int_0^R Tr dr - T \right]$$

$$\sigma_{zz} = \frac{\alpha E}{1 - 2\nu} [\overline{T} - T]$$

But

$$\epsilon_{zz} = \alpha T + \frac{(1 - \nu)}{E} \sigma_{zz}$$

$$\epsilon_{zz} = \frac{\alpha}{1 - 2\nu} (1 - \nu) T - \nu T$$

$$\epsilon_{zz} = \alpha T_s - \frac{\alpha kR^2}{(1-2\nu)8a} \left[ 1 + \nu + \frac{2\nu r^2}{R^2} \right]$$

and since the measurement is made at r = 0,

$$\Delta \varepsilon = \frac{\alpha (T_s - T_c) (1 + \nu)}{2(1 - 2\nu)}$$

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